## Notice of References Cited Application/Control No. 10/816,892 Examiner Christopher Bottorff Applicant(s)/Patent Under Reexamination HATSUDA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,799,284	03-1974	Hender, Berkeley Stephens	180/65.2
*	В	US-3,970,160	07-1976	Nowick, William	180/6.5
*	С	US-5,382,854	01-1995	Kawamoto et al.	310/67R
*	D	US-5,489,831	02-1996	Harris, William A.	318/701
*	E	US-6,089,341 A	07-2000	Gingerich, Newton Roy	180/65.1
*	F	US-6,449,552 B2	09-2002	Ohba et al.	701/89
*	G	US-6,549,835 B2	04-2003	Deguchi et al.	701/41
*	Н	US-6,573,675 B2	06-2003	Schmitz et al.	318/434
*	1	US-6,622,804 B2	09-2003	Schmitz et al.	180/65.2
*	J	US-6,688,412 B2	02-2004	Kima et al.	180/65.5
*	К	US-6,717,281 B1	04-2004	Brandon et al.	290/40C
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т			100		

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Kima et al., US Patent Application Publication 2002/0023791 A1, February 28, 2002.
	<b>V</b>	Niwa et al., US Patent Application Publication 2002/0039459 A1, April 4, 2002.
	W	Morrow et al., US Patent Application Publication, 2003/0205422 A1, November 6, 2003.
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.